

## Correction to “Thin Films and Bulk Phases Conucleate at the Interfaces of Pentacene Thin Films”

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This correction enumerates the following changes to the original publication:

1. An additional author (Greg Haugstad) is added to the original author list.
2. The description of the Atomic Force Microscopy section of the Experimental Section should read as follows:

### ■ ATOMIC FORCE MICROSCOPY (AFM)

A Keysight 5500 scanning probe microscope was operated in contact mode using a model 9524B  $90 \times 90 \times 8 \mu\text{m}$  scanner. The latter was freshly Z-recalibrated 3–4 days prior to this work (both Z scanner and Z sensor) using a model TGZ03 511 nm-step calibration grating from MikroMasch. The instrument was operated in closed loop X-Y. Z sensor images were processed to obtain all height information reported. A cantilever/tip (type FORT from Applied Nanostructures) was used for all images reported. Surface tracking was actuated at  $\sim 10\text{--}20 \text{ nN}$  of the applied load. Height images were subsequently leveled by subtracting a fitted plane function. Z sensor measurements on subregions on film and bare substrate (two terraces) were processed into two-peak height histograms. Mean and standard deviation film thickness measurements were produced from this analysis as demonstrated in the Supporting Information.

3. The Acknowledgment should read as corrected here.

### ■ ACKNOWLEDGMENTS

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